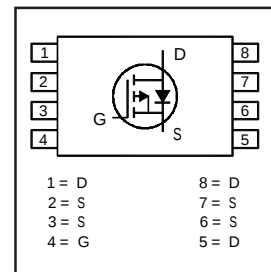


- Ultra Low On-Resistance
- -1.8V Rated
- P-Channel MOSFET
- Very Small SOIC Package
- Low Profile (< 1.1mm)
- Available in Tape & Reel

V_{DS}	$R_{DS(on)}$ max	I_D
-12V	0.014@ $V_{GS} = -4.5V$	-8.0A
	0.019@ $V_{GS} = -2.5V$	-7.0A
	0.027@ $V_{GS} = -1.8V$	-5.8A

Description

HEXFET® Power MOSFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the ruggedized device design, that International Rectifier is well known for, provides the designer with an extremely efficient and reliable device for battery and load management.



The TSSOP-8 package has 45% less footprint area than the standard SO-8. This makes the TSSOP-8 an ideal device for applications where printed circuit board space is at a premium. The low profile (<1.1mm) allows it to fit easily into extremely thin environments such as portable electronics and PCMCIA cards.

Absolute Maximum Ratings

	Parameter	Max.	Units
V_{DS}	Drain- Source Voltage	-12	V
I_D @ $T_C = 25^\circ C$	Continuous Drain Current, V_{GS} @ -4.5V	±8.0	A
I_D @ $T_C = 70^\circ C$	Continuous Drain Current, V_{GS} @ -4.5V	±7.0	
I_{DM}	Pulsed Drain Current ①	±70	
P_D @ $T_C = 25^\circ C$	Power Dissipation	1.5	W
P_D @ $T_C = 70^\circ C$	Power Dissipation	0.96	
	Linear Derating Factor	0.01	W/°C
V_{GS}	Gate-to-Source Voltage	± 8.0	V
T_J, T_{STG}	Junction and Storage Temperature Range	-55 to + 150	°C

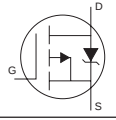
Thermal Resistance

	Parameter	Max.	Units
$R_{\theta JA}$	Maximum Junction-to-Ambient ③	83	°C/W

Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	-12	—	—	V	$V_{GS} = 0V$, $I_D = -250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	-0.007	—	V/ $^\circ\text{C}$	Reference to 25°C , $I_D = -1mA$
$R_{DS(on)}$	Static Drain-to-Source On-Resistance	—	—	0.014	Ω	$V_{GS} = -4.5V$, $I_D = -8.0A$ ②
		—	—	0.019		$V_{GS} = -2.5V$, $I_D = -7.0A$ ②
		—	—	0.027		$V_{GS} = -1.8V$, $I_D = -5.8A$ ②
$V_{GS(th)}$	Gate Threshold Voltage	-0.45	—	-1.2	V	$V_{DS} = V_{GS}$, $I_D = -250\mu A$
g_{fs}	Forward Transconductance	26	—	—	S	$V_{DS} = -10V$, $I_D = -8.0A$
I_{DSS}	Drain-to-Source Leakage Current	—	—	1.0	μA	$V_{DS} = -12V$, $V_{GS} = 0V$
		—	—	-25		$V_{DS} = -9.6V$, $V_{GS} = 0V$, $T_J = 70^\circ\text{C}$
I_{GSS}	Gate-to-Source Forward Leakage	—	—	-100	nA	$V_{GS} = -8.0V$
	Gate-to-Source Reverse Leakage	—	—	100		$V_{GS} = 8.0V$
Q_g	Total Gate Charge	—	54	81	nC	$I_D = -8.0A$
Q_{gs}	Gate-to-Source Charge	—	7.8	12		$V_{DS} = -9.6V$
Q_{gd}	Gate-to-Drain ("Miller") Charge	—	15	23		$V_{GS} = -4.5V$ ②
$t_{d(on)}$	Turn-On Delay Time	—	16	—	ns	$V_{DD} = -6.0V$
t_r	Rise Time	—	21	—		$I_D = -1.0A$
$t_{d(off)}$	Turn-Off Delay Time	—	320	—		$R_D = 6.0\Omega$
t_f	Fall Time	—	250	—		$R_G = 6.0\Omega$ ②
C_{iss}	Input Capacitance	—	3470	—	pF	$V_{GS} = 0V$
C_{oss}	Output Capacitance	—	1040	—		$V_{DS} = -10V$
C_{rss}	Reverse Transfer Capacitance	—	670	—		$f = 1.0MHz$

Source-Drain Ratings and Characteristics

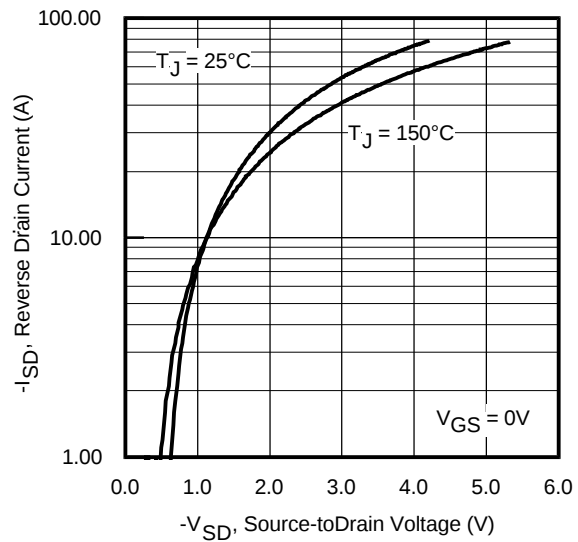
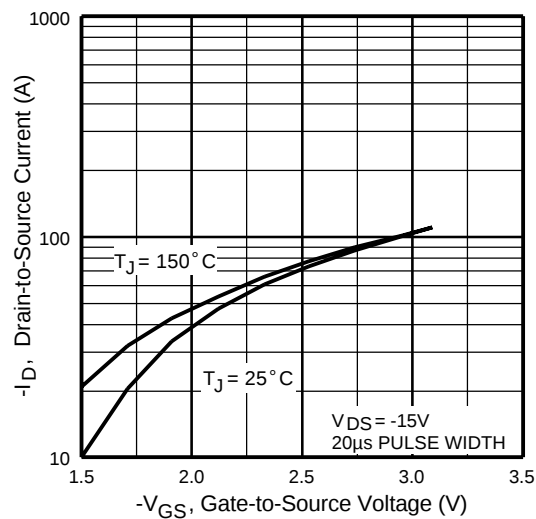
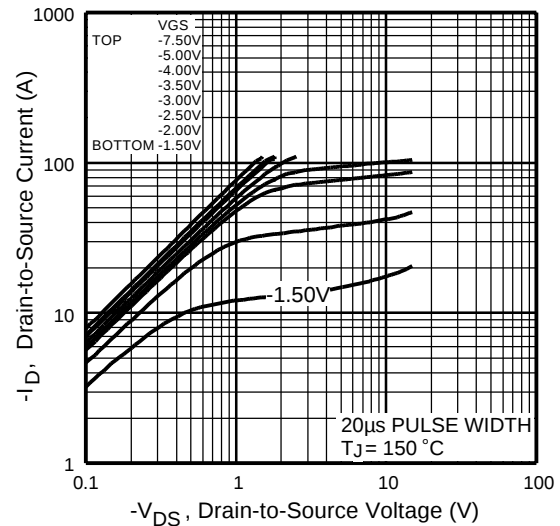
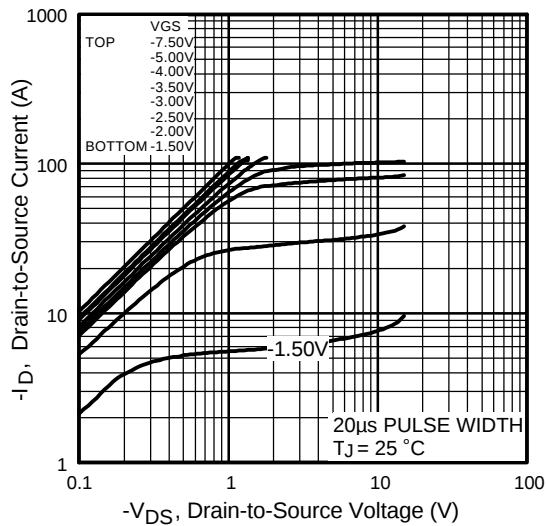
	Parameter	Min.	Typ.	Max.	Units	Conditions
I_S	Continuous Source Current (Body Diode)	—	—	-1.5	A	MOSFET symbol showing the integral reverse p-n junction diode. 
I_{SM}	Pulsed Source Current (Body Diode) ①	—	—	-70		
V_{SD}	Diode Forward Voltage	—	—	-1.2	V	$T_J = 25^\circ\text{C}$, $I_S = -1.5A$, $V_{GS} = 0V$ ②
t_{rr}	Reverse Recovery Time	—	58	87	ns	$T_J = 25^\circ\text{C}$, $I_F = -1.5A$
Q_{rr}	Reverse Recovery Charge	—	41	62	nC	$di/dt = 100A/\mu s$ ②

Notes:

① Repetitive rating; pulse width limited by max. junction temperature.

② Pulse width $\leq 300\mu s$; duty cycle $\leq 2\%$.

③ When mounted on 1 inch square copper board, $t < 10$ sec



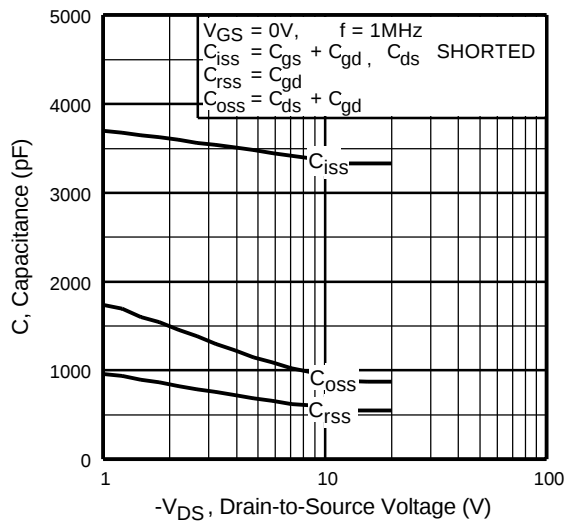


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

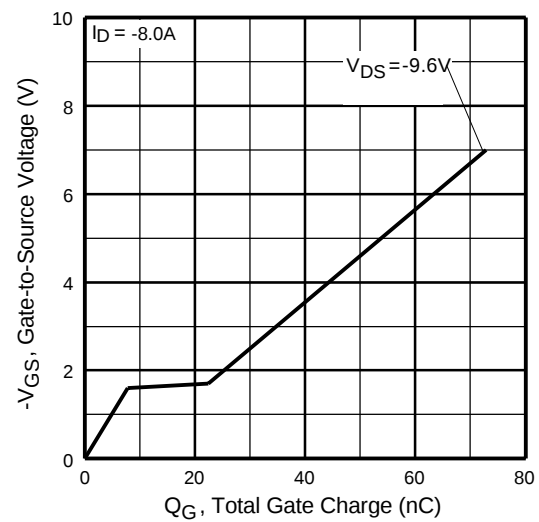


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

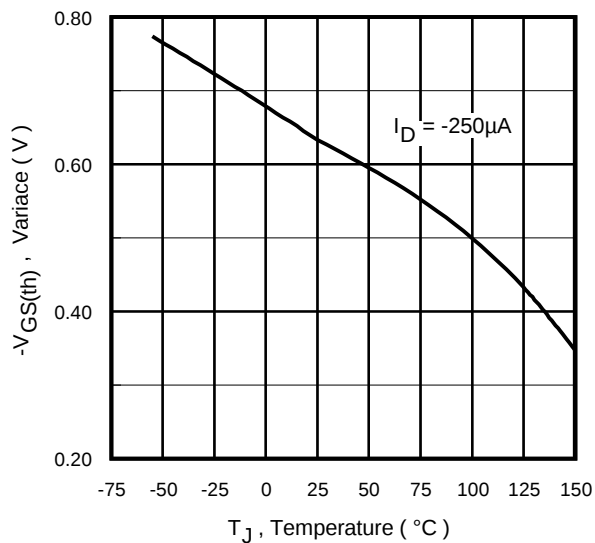


Fig 7. Threshold Voltage Vs. Temperature

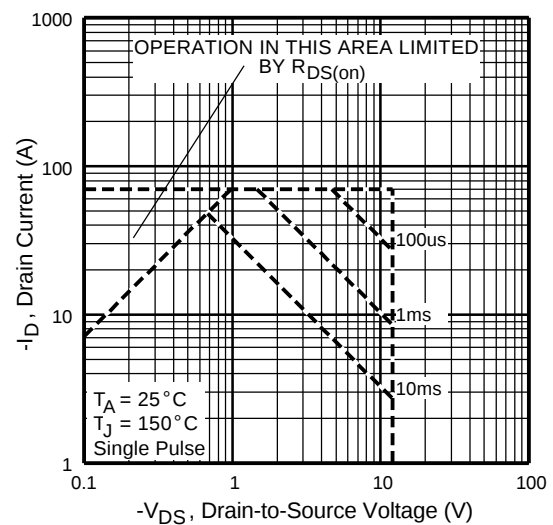


Fig 8. Maximum Safe Operating Area

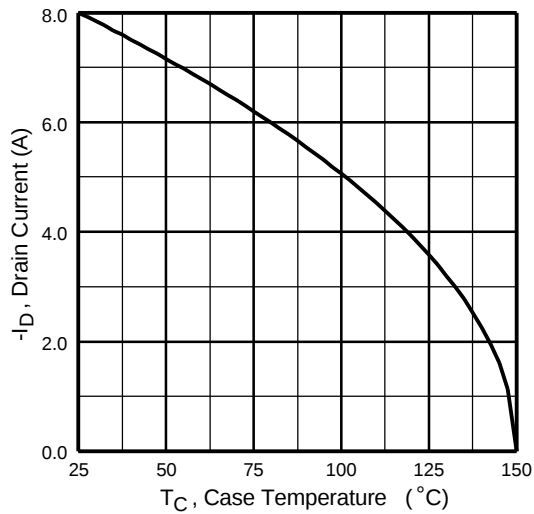


Fig 9. Maximum Drain Current Vs. Case Temperature

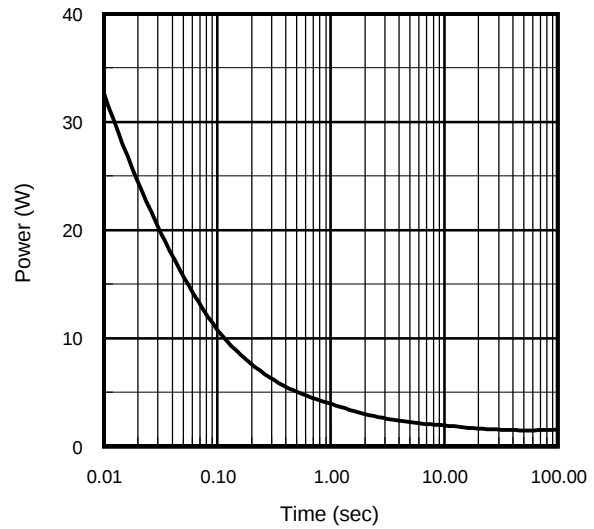


Fig 10. Typical Power Vs. Time

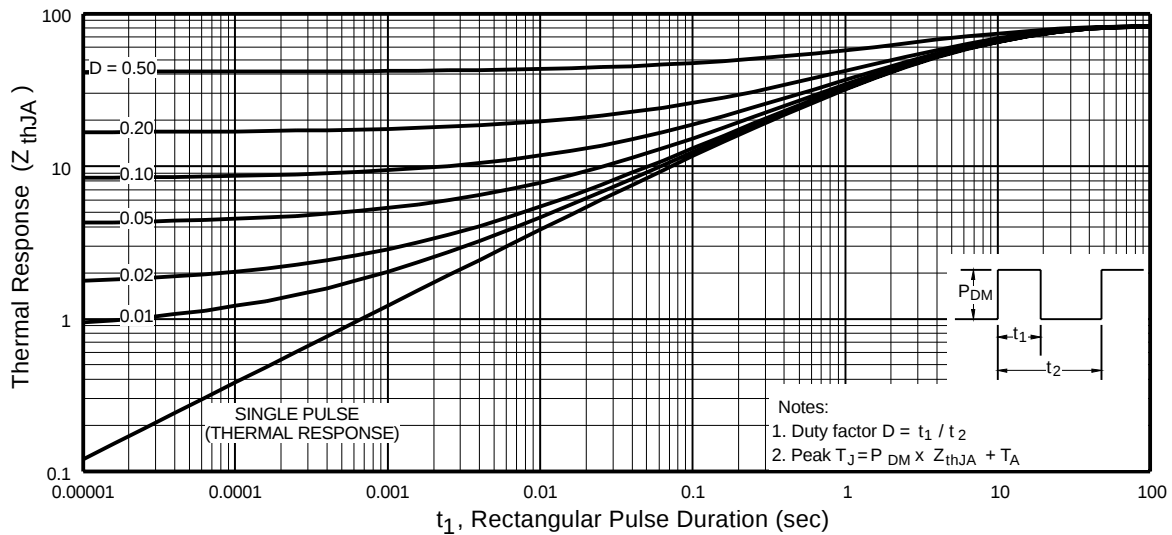


Fig 11. Typical Effective Transient Thermal Impedance, Junction-to-Ambient

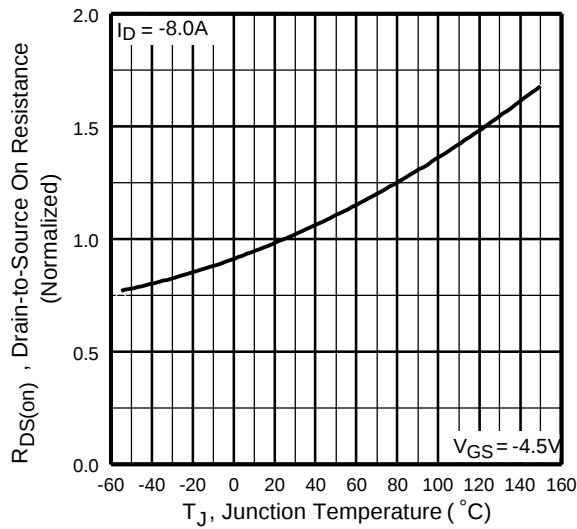


Fig 12. Normalized On-Resistance Vs. Temperature

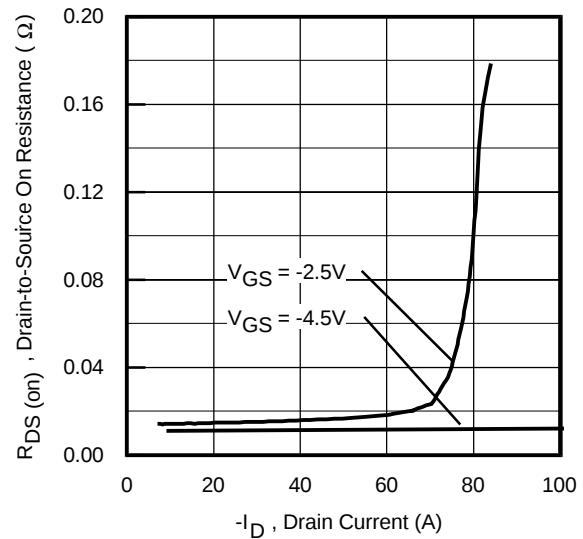


Fig 13. Typical On-Resistance Vs. Drain Current

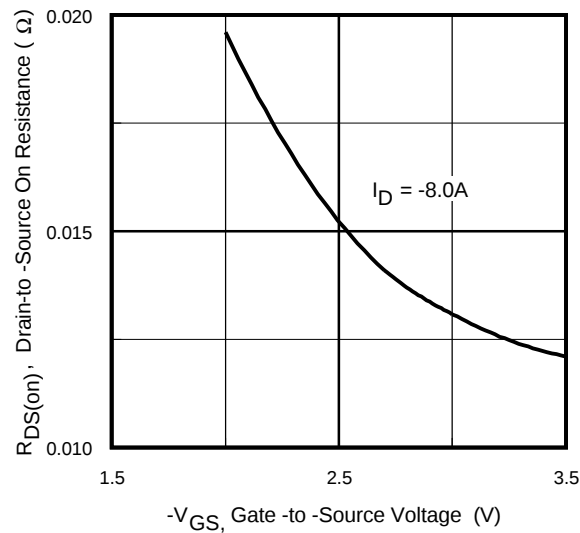
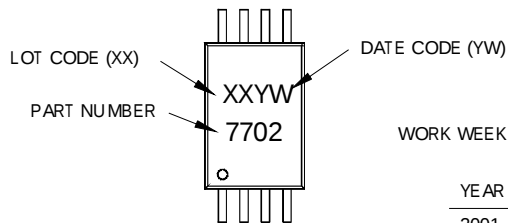


Fig 14. Typical On-Resistance Vs. Gate Voltage

TSSOP-8 Part Marking Information

EXAMPLE: THIS IS AN IRF7702



DATE CODE EXAMPLES:

9503 = 5C
9532 = EF

TABLE 1

WORK WEEK 1-26, NUMERIC YEAR CODE (1,2, ...,ETC.)

YEAR	Y	WORK WEEK	W
2001	1	01	A
2002	2	02	B
2003	3	03	C
1994	4	04	D
1995	5		
1996	6		
1997	7		
1998	8		
1999	9		
2000	0	24	X
		25	Y
		26	Z

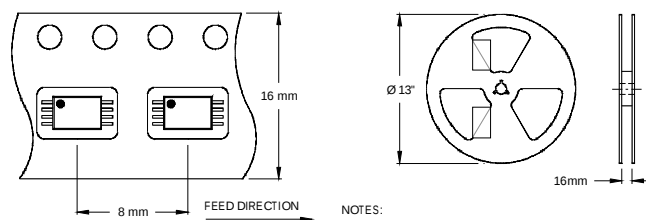
TABLE 2

WORK WEEK 27-52, ALPHANUMERIC YEAR CODE (A,B, ...ETC.)

YEAR	Y	WORK WEEK	W
2001	A	27	A
2002	B	28	B
2003	C	29	C
1994	D	30	D
1995	E		
1996	F		
1997	G		
1998	H		
1999	J		
2000	K	50	X
		51	Y
		52	Z

TSSOP-8 Tape and Reel

8LTSSOP (MO-153AA)



NOTES:

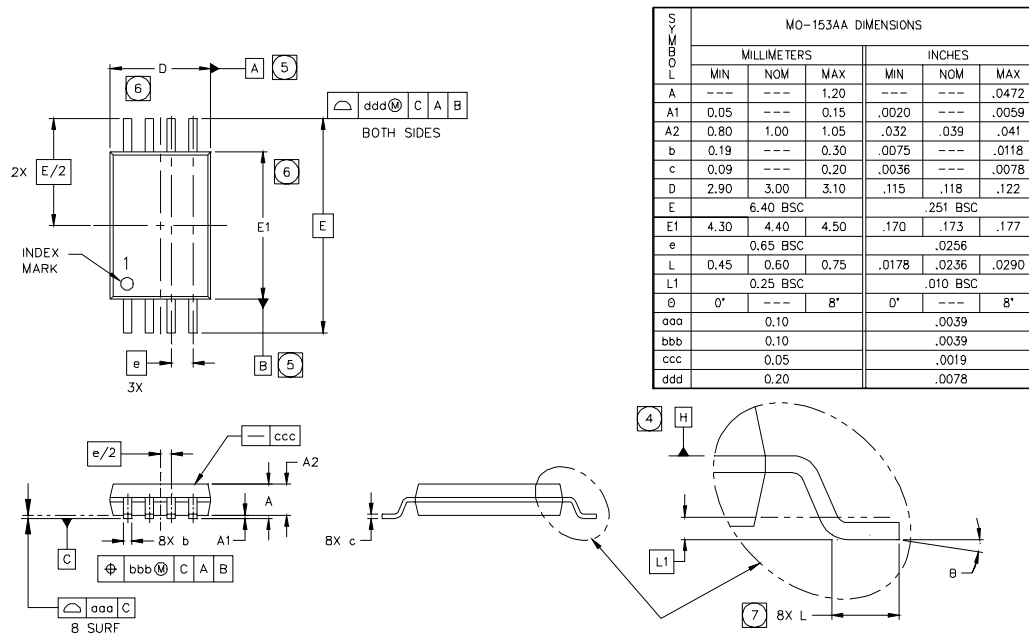
1. TAPE & REEL OUTLINE CONFORMS TO EIA-481 & EIA-541.

IRF7702

PROVISIONAL

International
IR Rectifier

TSSOP-8 Package Outline



NOTES

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.
- DIMENSIONS ARE SHOWN IN MILLIMETERS AND INCHES.
- CONTROLLING DIMENSION: MILLIMETER.
- DATUM PLANE H IS LOCATED AS SHOWN.
- DATUM A AND B TO BE DETERMINED AT DATUM PLANE H.
- DIMENSIONS D AND E1 ARE MEASURED AT DATUM PLANE H.
- DIMENSION L IS THE LEAD LENGTH FOR SOLDERING TO A SUBSTRATE.
- OUTLINE CONFORMS TO JEDEC OUTLINE MO-153AA.

LEAD ASSIGNMENTS



International
IR Rectifier

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IR CANADA: 15 Lincoln Court, Brampton, Ontario L6T3Z2, Tel: (905) 453 2200
IR GERMANY: Saalburgstrasse 157, 61350 Bad Homburg Tel: ++ 49 (0) 6172 96590
IR ITALY: Via Liguria 49, 10071 Borgaro, Torino Tel: ++ 39 011 451 0111
IR JAPAN: K&H Bldg., 2F, 30-4 Nishi-Ikebukuro 3-Chome, Toshima-Ku, Tokyo 171 Tel: 81 (0)3 3983 0086
IR SOUTHEAST ASIA: 1 Kim Seng Promenade, Great World City West Tower, 13-11, Singapore 237994 Tel: ++ 65 (0)838 4630
IR TAIWAN: 16 Fl. Suite D. 207, Sec. 2, Tun Haw South Road, Taipei, 10673 Tel: 886-(0)2 2377 9936
Data and specifications subject to change without notice. 6/00